LM3150 Evaluation Boards

National Semiconductor Application Note 1900 Maurice Eaglin October 14, 2008



Introduction

The LM3150 evaluation boards are designed to provide the design engineer with a fully functional power converter based on Constant On-Time with Emulated Ripple mode control to evaluate the LM3150 and the entire LM315x family of parts. The evaluation board is pre-configured to use the LM3150 with the output voltage pre-set to 3.3V, with a typical max load current of 10A. There are three different boards that are configured for 250 kHz, 500 kHz, and 750 kHz respectively. The printed circuit board consists of 4 layers of FR4 material with the top and bottom layers using 2 ounce copper and the inner layers using 1 ounce copper. The board size is 2.9" X 2.9".

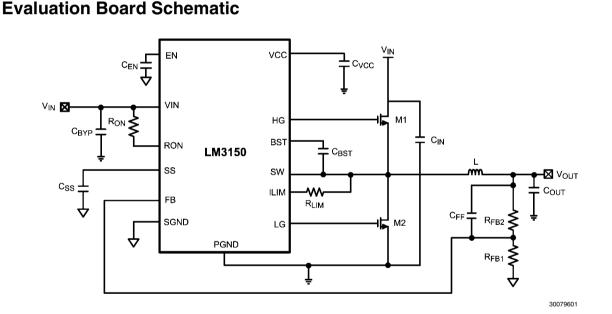
The evaluation board allows for a variety of configurations, and this multifunctional capability is used to also accept the fixed output versions of the LM3150 such as the LM3151-3.3, LM3152-3.3, and the LM3153-3.3.

The performance of the synchronous rectifier buck evaluation boards are as follows:

Switching Frequency: 250 kHz Input Range: 6V to 42V Output Voltage: 3.3V Output Current: 0 to 10A

Switching Frequency: 500 kHz Input Range: 6V to 24V Output Voltage: 3.3V Output Current: 0 to 10A

Switching Frequency: 750 kHz Input Range: 8V to 17V Output Voltage: 3.3V Output Current: 0 to 10A



Powering and Loading Considerations

Read this entire page prior to attempting to power the evaluation board.

QUICK SETUP PROCEDURE

Step 1: Set the input power supply current limit to 10A. Turn off the input power supply. Connect the power supply to the V_{IN} terminals.

Step 2: Connect the load, with up to 10A capability, to the $V_{\rm O}$ terminals. Positive connection to $V_{\rm O}$ and the negative connection to GND.

Step 3: The EN pin should be left open for normal operation.

Step 4: Set the input source voltage to 12V and the load to 0.1A. The load voltage should be in regulation with a nominal 3.3V output.

Step 5: Slowly increase the load current while monitoring the load voltage at the V_0 and GND terminals. It should remain in regulation with a nominal 3.3V output as the load is increased up to 10A.

Step 6: Slowly sweep the input source voltage over the operating voltage range corresponding to selected evaluation board as indicated in the introduction section. The load voltage should remain in regulation with a nominal 3.3V output.

Step 7: The shutdown function can be verified by applying 0V to the EN pin.

TESTING THE FIXED VERSION PARTS

The fixed output versions can also be mounted on the LM3150 evaluation boards with few modifications to the default configuration as indicated below. This is achievable because the pins 7 and 8 are not internally connected on the fixed version parts.

- 1. Replace U1, LM3150, with a fixed version part such as the LM3152
- 2. Short Rfb2
- 3. Remove Rfb1
- 4. Remove Cff

Ensure that the remaining components on the evaluation board will meet your design specifications by using the provided circuit calculator tools.

ALTERNATE RIPPLE INJECTION

Certain designs may benefit from another ripple injection technique that utilizes a resistor and capacitor to integrate the voltage across the inductor and then couple that signal through a capacitor to the FB pin. This technique is commonly found in COT controllers and may benefit designs that have high output voltage such as 12V and a low-side FET that has a low R_{DSON} and require low output voltage ripple. The evaluation board allows for this configuration allowing the placement of Rr, Cr, and Cac. After the proper components for Rr, Cr, and Cac have been chosen mount them on the evaluation board and remove Cff.

A quick efficiency check is the best way to confirm that everything is operating properly. If something is amiss you can be reasonably sure that it will affect the efficiency adversely. Few parameters can be incorrect in a switching power supply without creating losses and potentially damaging heat.

IMPROVING EFFICIENCY

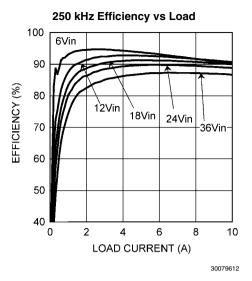
It is also well known that efficiency may be improved slightly by placing a schottky diode across the low-side FET. The schottky diode has a much lower forward voltage drop than the internal diode of the FET and a faster turn-on time. This evaluation board allows for a schottky diode to be placed on footprint D1.

The internal VCC regulator provides a supply voltage to both the high-side and low-side FET drivers. The high-side FET driver receives it's supply voltage through a internal diode that has a forward voltage drop as high as 1V. This may impact the drivers ability to turn on the high-side FET fully and therefore cause a loss in efficiency depending upon which FET is chosen. The footprint Dbst allows for placement of a schottky diode that will have a much smaller forward drop and therefore increase the driver supply voltage and allow for improved efficiency for certain FETs.

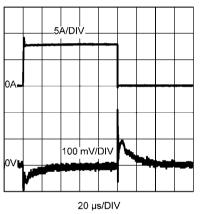
OUTPUT VOLTAGE RIPPLE MEASUREMENT

The output voltage ripple measurement is usually taken directly across the output capacitors utilizing extremely short scope probe leads. To help make this measurement slightly easier, a footprint Cf has been included that will allow for a 1 μF or less 0805 or 1206 capacitor to be mounted directly across the output voltage terminals that will allow for approximate measurement of the ripple voltage.

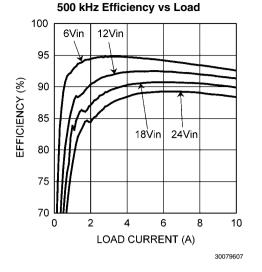
Performance Characteristics



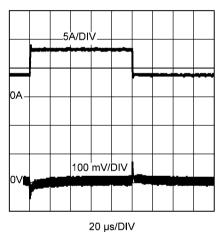
500 kHz Full Load Transient



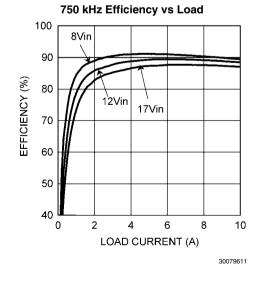
30079608



500 kHz Partial Load Transient

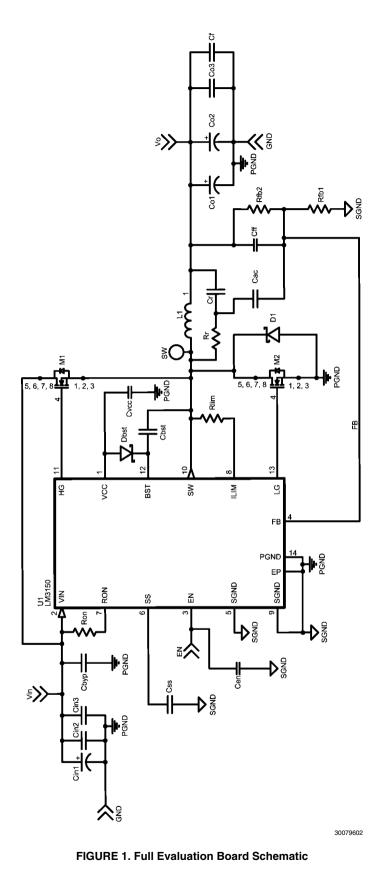


30079610





Full Schematic



Layout and Bill of Materials

The Bill of Materials is shown below, including the manufacturer and part number.

DESIGNATOR QTY PART NUMBER DESCRIPTION VALUE VENDOR U1 1 LM3150MH Simple Switcher Controller LM3150 National Semiconductor Ceramic, X7R, 16V, 10% TDK Cbst 1 C2012X7R1C474K 0.47 µF Ceramic, X7R, 50V, 10% 0.100 µF TDK Cbyp 1 C2012X7R1H104K Ceramic, X7R, 50V, 10% TDK Cen 1 C1608X7R1H102K 1000 pF Cff Ceramic, X7R, 50V, 10% 560 pF 1 VJ0805Y561KXACW1BC Vishay 2 Cin1, Cin2 50HVH56M Aluminum Electrolytic, 50V, 20% 56 µF Sanyo Co1, Co2 2 PCF0J221MCL1GS Polymer Aluminum, 6.3V, 20% 220 µF Nichicon Css 1 VJ0805Y683KXXA Ceramic, 0805, 25V, 10% 0.068 µF Vishay Cvcc 1 C0805C105K4RACTU Ceramic, X7R, 16V, 10% 1μF Kemet ΕN 1 Terminal, Single Pin White Keystone 5002 L1 1 Coilcraft SER2013-362ML 3.6 µH Shielded Drum Core, 1.82 mΩ M1 1 SI7850DP 60V Vishay NFET, $R_{DS(ON)}$ @4.5V=25 m Ω SI7478DP Vishav M2 1 NFET, R_{DS(ON)} @4.5V=8.8 mΩ 60V PGND, PGND, Vin, Vo 4 Turret Terminal Triple Keystone 1598-2 1 Rfb1 CRCW08054K99FKEA 1%, 0.125W 4.99 kΩ Vishay Rfb2 1 CRCW080522K6FKEA 1%, 0.125W Vishay 22.6 kΩ Rlim Vishay 1 CRCW08051K40FKEA 1%, 0.125W 1.40 kΩ Ron 1 CRCW0805115KFKEA 1%. 0.125W Vishay 115 kΩ SW 1 5015 Surface Mount Test Point Keystone Rr, Cr, Cin3, Cac, Not Installed, See Text Dbst, D1

TABLE 1. 250 kHz Bill of Materials

AN-1900

TABLE 2. 500 kHz Bill of Materials

DESIGNATOR	QTY	PART NUMBER	DESCRIPTION	VALUE	VENDOR
U1	1	LM3150MH	Simple Switcher Controller	LM3150	National
					Semiconductor
Cbst	1	C2012X7R1C474K	Ceramic, X7R, 16V, 10%	0.47 µF	TDK
Cbyp	1	C2012X7R1H104K	Ceramic, X7R, 50V, 10%	0.100 µF	TDK
Cen	1	C1608X7R1H102K	Ceramic, X7R, 50V, 10%	1000 pF	TDK
Cff	1	VJ0805A271JXACW1BC	Ceramic, X7R, 50V, 10%	270 pF	Vishay
Cin1	1	EEVFK1J101P	Aluminum Electrolytic, , 63V, 20%	100 µF	Panasonic
Cin2, Cin3	2	GMK325BJ106KN-T	Ceramic, X7R, 50V, 20%	10 µF	Taiyo Yuden
Co1, Co2	2	EEF-UE0J151R	Polymer Aluminum, 6.3V, 20%	150 µF	Panasonic
Css	1	VJ0805Y683KXXA	Ceramic, 0805, 25V, 10%	0.068 µF	Vishay
Cvcc	1	C0805C105K4RACTU	Ceramic, X7R, 16V, 10%	1 µF	Kemet
EN	1	5002	Terminal, Single Pin	White	Keystone
L1	1	MVR1271C-162ML	Shielded Drum Core, 2.53 m Ω	1.65 µH	Coilcraft
M1,M2	2	RJK0305DPB	NFET, R _{DS(ON)} @4.5V=10 mΩ	30V	Renesas
PGND, PGND, Vin, Vo	4	1598-2	Turret Terminal	Triple	Keystone
Rfb1	1	CRCW08054K99FKEA	1%, 0.125W	4.99 kΩ	Vishay
Rfb2	1	CRCW080522K6FKEA	1%, 0.125W	22.6 kΩ	Vishay
Rlim	1	CRCW08051K91FKEA	1%, 0.125W	1.91 kΩ	Vishay
Ron	1	CRCW080556K2FKEA	1%, 0.125W	56.2 kΩ	Vishay
SW	1	5015	Surface Mount Test Point		Keystone
Rr, Cr, Cac, Dbst, D1			Not Installed, See Text		

TABLE 3. 750 kHz Bill of Materials

DESIGNATOR	QTY	PART NUMBER	DESCRIPTION	VALUE	VENDOR
U1	1	LM3150MH	Simple Switcher Controller	LM3150	National Semiconducto
Cbst	1	C2012X7R1C474K	Ceramic, X7R, 16V, 10%	0.47 µF	TDK
Сbyp	1	C2012X7R1H104K	Ceramic, X7R, 50V, 10%	0.100 µF	TDK
Cen	1	C1608X7R1H102K	Ceramic, X7R, 50V, 10%	1000 pF	TDK
Cff	1	CC0805JRNP09BN151	Ceramic, NP0, 50V, 5%	150 pF	Yageo
Cin1	1	EEE-FK1V151P	Aluminum Electrolytic, 63V, 20%	150 µF	Panasonic
Cin2, Cin3	2	GMK325BJ106KN-T	Ceramic, X7R, 50V, 20%	10 µF	Taiyo Yuden
Co1, Co2	2	EEF-UE0J151R	Polymer Aluminum, 6.3V, 20%	150 µF	Panasonic
Css	1	VJ0805Y683KXXA	Ceramic, 0805, 25V, 10%	0.068 µF	Vishay
Cvcc	1	C0805C105K4RACTU	Ceramic, X7R, 16V, 10%	1μF	Kemet
EN	1	5002	Terminal, Single Pin	White	Keystone
L1	1	XPL7030-102ML	Shielded Drum Core, 1.9 m Ω	1 µH	Coilcraft
M1	1	RJK0305DPB	NFET, R _{DS(ON)} @4.5V=10 mΩ	30V	Renesas
M2	1	RJK0329DPB	NFET, R _{DS(ON)} @4.5V=2.4 mΩ	30V	Renesas
PGND, PGND, Vin, Vo	4	1598-2	Turret Terminal	Triple	Keystone
Rfb1	1	CRCW08054K99FKEA	1%, 0.125W	4.99 kΩ	Vishay
Rfb2	1	CRCW080522K6FKEA	1%, 0.125W	22.6 kΩ	Vishay
Rlim	1	CRCW08051K91FKEA	1%, 0.125W	1.91 kΩ	Vishay
Ron	1	CRCW080556K2FKEA	1%, 0.125W	56.2 kΩ	Vishay
SW	1	5015	Surface Mount Test Point		Keystone
Rr, Cr, Cac, Dbst, D1			Not Installed, See Text		

PCB Layout

Cini Cin2 Cin3 ullet1(GND M2 ::: ***** lacksquareD1 🕯 GND igodol

 National
 LM315x Evaluation Board

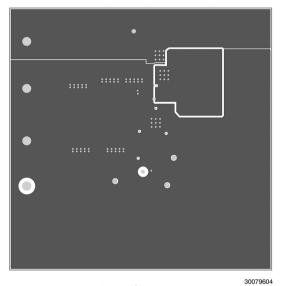
 Semiconductor
 250kHz

 Made in US c 2008 NSC
 750kHz

 \cap 250kHz 500kHz 750kHz

Top Layer

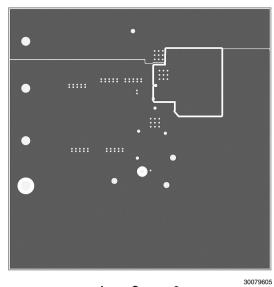
30079603



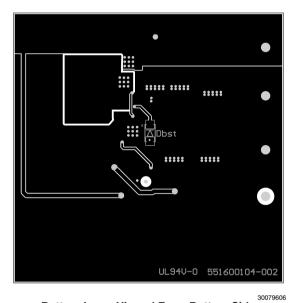
Inner Copper 1

AN-1900

AN-1900







Bottom Layer Viewed From Bottom Side

AN-1900

Notes

Pr	oducts	Design Support		
Amplifiers	www.national.com/amplifiers	WEBENCH	www.national.com/webench	
Audio	www.national.com/audio	Analog University	www.national.com/AU	
Clock Conditioners	www.national.com/timing	App Notes	www.national.com/appnotes	
Data Converters	www.national.com/adc	Distributors	www.national.com/contacts	
Displays	www.national.com/displays	Green Compliance	www.national.com/quality/green	
Ethernet	www.national.com/ethernet	Packaging	www.national.com/packaging	
Interface	www.national.com/interface	Quality and Reliability	www.national.com/quality	
LVDS	www.national.com/lvds	Reference Designs	www.national.com/refdesigns	
Power Management	www.national.com/power	Feedback	www.national.com/feedback	
Switching Regulators	www.national.com/switchers			
LDOs	www.national.com/ldo			
LED Lighting	www.national.com/led			
PowerWise	www.national.com/powerwise			
Serial Digital Interface (SDI)	www.national.com/sdi			
Temperature Sensors	www.national.com/tempsensors			
Wireless (PLL/VCO)	www.national.com/wireless			

THE CONTENTS OF THIS DOCUMENT ARE PROVIDED IN CONNECTION WITH NATIONAL SEMICONDUCTOR CORPORATION ("NATIONAL") PRODUCTS. NATIONAL MAKES NO REPRESENTATIONS OR WARRANTIES WITH RESPECT TO THE ACCURACY OR COMPLETENESS OF THE CONTENTS OF THIS PUBLICATION AND RESERVES THE RIGHT TO MAKE CHANGES TO SPECIFICATIONS AND PRODUCT DESCRIPTIONS AT ANY TIME WITHOUT NOTICE. NO LICENSE, WHETHER EXPRESS, IMPLIED, ARISING BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT.

TESTING AND OTHER QUALITY CONTROLS ARE USED TO THE EXTENT NATIONAL DEEMS NECESSARY TO SUPPORT NATIONAL'S PRODUCT WARRANTY. EXCEPT WHERE MANDATED BY GOVERNMENT REQUIREMENTS, TESTING OF ALL PARAMETERS OF EACH PRODUCT IS NOT NECESSARILY PERFORMED. NATIONAL ASSUMES NO LIABILITY FOR APPLICATIONS ASSISTANCE OR BUYER PRODUCT DESIGN. BUYERS ARE RESPONSIBLE FOR THEIR PRODUCTS AND APPLICATIONS USING NATIONAL COMPONENTS. PRIOR TO USING OR DISTRIBUTING ANY PRODUCTS THAT INCLUDE NATIONAL COMPONENTS, BUYERS SHOULD PROVIDE ADEQUATE DESIGN, TESTING AND OPERATING SAFEGUARDS.

EXCEPT AS PROVIDED IN NATIONAL'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, NATIONAL ASSUMES NO LIABILITY WHATSOEVER, AND NATIONAL DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY RELATING TO THE SALE AND/OR USE OF NATIONAL PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS PRIOR WRITTEN APPROVAL OF THE CHIEF EXECUTIVE OFFICER AND GENERAL COUNSEL OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

Life support devices or systems are devices which (a) are intended for surgical implant into the body, or (b) support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in a significant injury to the user. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system or to affect its safety or effectiveness.

National Semiconductor and the National Semiconductor logo are registered trademarks of National Semiconductor Corporation. All other brand or product names may be trademarks or registered trademarks of their respective holders.

Copyright© 2008 National Semiconductor Corporation

For the most current product information visit us at www.national.com



National Semiconductor Americas Technical Support Center Email: support@nsc.com Tel: 1-800-272-9959 National Semiconductor Europe Technical Support Center Email: europe.support@nsc.com German Tel: +49 (0) 180 5010 771 English Tel: +44 (0) 870 850 4288 National Semiconductor Asia Pacific Technical Support Center Email: ap.support@nsc.com National Semiconductor Japan Technical Support Center Email: jpn.feedback@nsc.com